Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

# 2SC4781

# Strobe Flash Applications Medium Power Amplifier Applications

• High DC current gain and Excellent hFE linearity

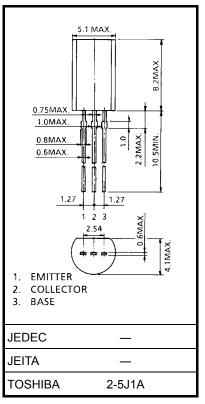
:  $h_{FE}(1) = 200 \text{ to } 600 \text{ (V}_{CE} = 2 \text{ V}, I_{C} = 1 \text{ A)}$ 

:  $h_{FE}$  (2) = 300 (typ.) ( $V_{CE}$  = 2 V,  $I_{C}$  = 4 A)

• Low saturation voltage: VCE (sat) = 0.5 V (max) (IC = 4 A, IB = 80 mA)

#### Absolute Maximum Ratings (Ta = 25°C)

| Characteristics             |        | Symbol           | Rating     | Unit |  |
|-----------------------------|--------|------------------|------------|------|--|
| Collector-base voltage      |        | $V_{CBO}$        | 30         | V    |  |
| Collector-emitter voltage   |        | V <sub>CES</sub> | 30         | V    |  |
|                             |        | V <sub>CEO</sub> | 10         |      |  |
| Emitter-base voltage        |        | V <sub>EBO</sub> | 6          | V    |  |
| Collector current           | DC     | IC               | 4          | А    |  |
|                             | Pulsed | I <sub>CP</sub>  | 8          |      |  |
| Base current                |        | ΙΒ               | 0.8        | Α    |  |
| Collector power dissipation |        | PC               | 900        | mW   |  |
| Junction temperature        |        | Tj               | 150        | °C   |  |
| Storage temperature range   |        | T <sub>stg</sub> | -55 to 150 | °C   |  |



Weight: 0.36 g (typ.)

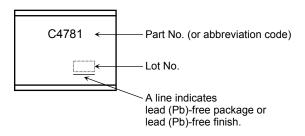
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## Electrical Characteristics (Ta = 25°C)

| Characteristics                      | Symbol                | Test Condition  | Min | Тур. | Max | Unit |
|--------------------------------------|-----------------------|---|-----|------|-----|------|
| Collector cut-off current            | I <sub>CBO</sub>      | V <sub>CB</sub> = 30 V, I <sub>E</sub> = 0            | _   | _    | 100 | nA   |
| Emitter cut-off current              | I <sub>EBO</sub>      | V <sub>EB</sub> = 6 V, I <sub>C</sub> = 0             | _   | _    | 100 | nA   |
| Collector-emitter breakdown voltage  | V (BR) CEO            | I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0            | 10  | _    | _   | V    |
| DC current gain                      | h <sub>FE (1)</sub>   | V <sub>CE</sub> = 2 V, I <sub>C</sub> = 1 A           | 200 | _    | 600 |      |
|                                      | h <sub>FE (2)</sub>   | V <sub>CE</sub> = 2 V, I <sub>C</sub> = 4 A           | 140 | 300  | _   |      |
| Collector-emitter saturation voltage | V <sub>CE</sub> (sat) | I <sub>C</sub> = 4 A, I <sub>B</sub> = 80 mA          | _   | 0.28 | 0.5 | V    |
| Base-emitter voltage                 | V <sub>BE</sub>       | V <sub>CE</sub> = 2 V, I <sub>C</sub> = 4 A           | _   | 1.0  | 1.5 | V    |
| Transition frequency                 | f <sub>T</sub>        | V <sub>CE</sub> = 2 V, I <sub>C</sub> = 0.5 A         | _   | 170  | _   | MHz  |
| Collector output capacitance         | C <sub>ob</sub>       | V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0, f = 1 MHz | _   | 50   | _   | pF   |

## Marking



#### **RESTRICTIONS ON PRODUCT USE**

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